On-chip light detection using monolithically integrated quantum dot micropillars

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We demonstrate the on-chip detection of light using photosensitive detectors based on quantum dot (QD) micropillar cavities. These microscale detectors are applied exemplarily to probe the emission of a monolithically integrated, electrically pumped whispering gallery mode microlaser. Light is detected via the photocurrent induced in the electrically contacted micropillar detectors under reverse-bias. In order to demonstrate the high potential and applicability of the microdetector presented, we determine the threshold current of an integrated microlaser to be $(54 \pm 4) \mu$A, in very good agreement with the value of $(53 \pm 4) \mu$A inferred from optical data. Within this work we realize the monolithic integration of a laser and a detector in a single device operating in the regime of cavity-quantum electrodynamics. Our results thus advance the research on microscale sensor technology towards the few-photon quantum limit and pave the way for on-chip opto-electronic feedback experiments.

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Integrated light sources [1, 2] and detectors [3, 4] have high potential to play a key role in future photonic devices. In particular, they can act as compact, low-power building blocks in optical communication and information technologies [5-7]. Within these fields, semiconductor quantum dots (QDs) and QD-microcavity systems show great promise for advancing integrated photonics not only in terms of light sources, but also with regard to detection. In fact, single-photon detection, crucial to quantum information processing, has been achieved using QDs in transistor- [8], resonant-tunneling diode- [9], and single-QD-based devices [10]. Integrating the QDs within a resonator further improves the light detection efficiency as well as the wavelength selectivity [11] and advances the research in the single-emitter regime of cavity-quantum electrodynamics (cQED) [12].

Regarding the generation of light, micropillar cavities with embedded QDs are particularly viable as integrated, electrically operated light sources as they exhibit high $Q$-factors and low mode volumes. As such, they provide cQED-enhanced light-matter interaction [13-15], which allows for the realization of low-threshold high-$\beta$ lasers for both vertically-propagating modes [16] and laterally-propagating whispering gallery modes (WGMs) [17, 18]. Further, due to their laterally directed emission, WGM microlasers are of special interest in the context of coherent light sources for on-chip quantum optical studies [19] and the generation of non-classical light [20], as well as for driving optical circuits due to their compatibility with planar photonic networks [21-23]. Moreover, integrating such lasers with microscale detectors opens up interesting perspectives, such as wavelength-selective microscale sensing applications and opto-electronic feedback experiments. The latter can lead to chaotic optical and electrical output behavior enabling, e.g., compact and ultrafast random number generators [24, 25]. In this view, the integration of laterally coupled laser-detector pairs is highly desirable as it allows for the realization of such opto-electronic feedback ensembles on a single chip.

In this letter, we report on the integration of a microscale photodetector into a cQED system. The QD-based on-chip microdetector is applied to characterize the emission from a monolithically integrated WGM microlaser via electrical readout of the photocurrent. In this configuration, we go a significant step beyond the conventional approach in which individual micropillars have been used as photosensitive devices under axial light incoupling [12]. In order to demonstrate the potential of our approach, we use a differential lock-in technique to probe the input-output curve of the integrated microlaser and to determine its threshold current.

A schematic of the integrated microlaser-photodetector pair is shown in Fig. 1(a). The sample is based on a planar microcavity structure grown by molecular beam epitaxy on an n-doped (100)-oriented GaAs substrate. Therein, n- and p-doped distributed Bragg reflectors with 27 and 23 $\lambda/4$ AlAs/GaAs mirror pairs are grown below and above an intrinsic GaAs $\lambda$-cavity, respectively. A single layer of self-organized InGaAs QDs (area density $\sim 10^{9}$ cm$^{-2}$) treated with partial capping and annealing processes [26] serves as gain medium located within the $\lambda$-cavity. From this wafer, micropillars with a diameter of 4 $\mu$m serving
as on-chip coherent light sources (via lasing WGM emission) were patterned by electron-beam lithography and reactive ion plasma etching. Surrounding the characterized microlaser is a group of five 1.6 µm-diameter peripheral micropillars, separated from the WGM microlaser by a distance of 15 µm, which act as monolithically integrated photodetectors (cf. inset, Fig. 1(a)).

A planarization step with the polymer benocyclobutene was followed by the application of Au pads serving as electrical contacts, with separate p-contacts for the laser bar and the detector bar [27].

The device was mounted on a chip carrier within a liquid-Helium flow cryostat and cooled to 25 K for electrical and optical characterization. The former was carried out with a source-measurement unit for direct current (DC) injection/bias application and an optional lock-in amplifier (LIA) providing a sinusoidal reference voltage output. The equivalent circuit diagram of the experiment can be seen in Fig. 1(b). The optical characterization was carried out in a micro-electroluminescence (µEL) setup featuring a 20× microscope objective (numerical aperture 0.42), a triple-grating monochromator with a spectral resolution of 85 µeV, and a liquid-nitrogen cooled charge-coupled device camera.

To compare and validate the results obtained from our on-chip detector concept, the WGM microlaser’s emission was first characterized in a conventional µEL setup to optically determine the input-output characteristic and the threshold current in off-chip configuration. For this purpose, the WGM laser emission scattered at marker structures located in the vicinity of the microlaser was collected via the microscope objective and spectra were recorded for injection currents up to 312 µA (see Fig. 2(a)). The microlaser was found to provide single mode emission at 852.6 nm with a Q-factor of 13,500 at threshold. The lasing mode was fitted in each case with a Voigt function, taking into account the spectral resolution of the setup, from which the full-width at half-maximum (FWHM) and integrated intensity were extracted. As seen in Fig. 2(b), at low injection currents, the WGM mode has a linewidth of 250 µeV. This is followed by a sudden decrease down to the resolution limit of the setup.
(85 µeV) at elevated currents, indicating the onset of lasing. Likewise, the input-output curve reveals a smooth transition into linear scaling around threshold. Its value was determined to be $I_{th} = (53 \pm 4) \mu A$ (at 6.2 V laser bias).

Reverse-biasing the peripheral micropillars allows one to electrically probe the microlaser emission. Once the WGM microlaser is turned on, the reverse current in the peripheral micropillars increases due to the generation of photocarriers within the active region. Photocurrent generation was also verified for each microdetector by individual excitation with an external tunable laser (not shown). Fig. 3(a) depicts $I-V$ curves (black) of the peripheral micropillars at no laser current (dashed) and at 312 µA (solid) by a direct measurement of the photocurrent (without LIA). At vanishing laser current, the moderately reverse-biased detectors show a dark current below 10 nA, while at about -10 V, the junction reaches breakdown. Upon laser emission, the reverse current increases by the amount of the extracted photocurrent (blue). Its value increases as the detector voltage is varied from 1.4 (flatband condition) to -9 V, since injected photocarriers are extracted with increasing efficiency from the QD ensemble due to enhanced tunneling processes [28]. At detector voltages below -9 V, photocarriers are multiplied by impact ionization, as apparent from the sudden increase in photocurrent. The breakdown voltage of the junction shifts slightly to -9 V, as a result of the additional impact-ionized photocarriers. This direct operation without the lock-in technique allowed a linear response to the optical emission (Fig. 2(a)) to be verified, see Fig. 3(b). The responsivity was found to be about 0.05 A/W for biases up to -8 V. Taking into account the dark current at this working point, this corresponds to a noise-equivalent power (NEP) of $6.3 \times 10^{-9}$ W/Hz$^{1/2}$. Further, by considering the effective detector area of the five coupled micropillar detectors, we gain an upper limit for the specific detectivity of $D^* = 1 \times 10^5$ cmHz$^{1/2}$/W. This rather moderate value is explained by the fact, that our detectors are based on a single low-density layer of InGaAs QDs (areal density ~ 10⁹ cm⁻²) in the active layer. We expect that $D^*$ can be significantly enhanced by 2-3 orders of magnitude via stacked layers (e.g. 10 layers) of QDs with high areal
density \(10^{10}-10^{11}\) cm\(^{-2}\) in the active region, which would result in a performance comparable to reports on QD [29] and quantum well [30]-based photodetectors utilizing nanophotonic approaches. Moreover, WGM microlasers with Limaçon-shaped cross-section, providing in-plane unidirectional emission into two light-cones [21], can strongly enhance the overall coupling efficiency of the integrated microlaser-microdetector system.

After demonstrating the capability of our highly integrated approach for on-chip photocurrent extraction, we apply this appealing feature exemplarily to infer the threshold current of the WGM microlaser, being a crucial parameter of coherent light sources. For this purpose, the circuit shown in Fig. 1(b) is utilized. The LIA allows us to apply a differential acquisition method which is particularly sensitive to a time-varying lasing mode intensity, as elaborated in the following. It can be inferred from the right branch of the circuit that the input voltage \(V_{\text{in}}\) to the LIA is given by

\[
V_{\text{in}}(t) = \frac{V_D}{(1 + R_D(t)/R)}.
\]

Approximating this expression in the limit \(R_D(t)/R \ll 1\) and \(R_P(t)/R \ll 1\) yields

\[
V_{\text{LIA}}(I_{\text{WGM}}) = \left(\frac{\alpha V_D}{\sqrt{2}}\right) \times \Delta P_{\text{opt}}(I_{\text{WGM}}) \times \left(\frac{\sqrt{2} \times P_{\text{opt}}(I_{\text{WGM}})}{(1 + R_0/R)^3} + \frac{1}{(1 + R_0/R)^2}\right).
\]

\[(1)\]

**Figure 3:** (a) \(I-V\) curves (black) of the peripheral micropillars at no laser current (dashed) and at a laser current of 312 \(\mu\)A (solid). The photocurrent at this laser current (blue) is calculated as the difference between the two \(I-V\) curves. Photocarriers injected by the WGM laser lead to an increased detector current and the former are extracted more efficiently from the QD ensemble at higher reverse biases, until junction breakdown at \(-9\) V initiates strong carrier multiplication. (b) The photodetector exhibits a linear response to the optical input power generated by the integrated WGM microlaser. The integrated intensity is deduced from \(\mu\)EL spectra exemplarily shown in Fig. 2(a).
Above threshold \((I_{\text{WGM}} > I_{\text{th}})\), Eq. (1) describes a function linear in \(I_{\text{WGM}}\) since \(P_{\text{opt}}\) is a linear function of \(I_{\text{WGM}}\) and hence \(\Delta P_{\text{opt}}(I_{\text{WGM}} > I_{\text{th}}) = \text{const.}\). Upon subtraction of this superimposed linear trend in the limit \(R_0/R \gg 1\), one obtains the pseudo-LIA voltage \(V_{\text{LIA}}^\dagger(I_{\text{WGM}}) \propto V_0 \times (\Delta P_{\text{opt}}(I_{\text{WGM}}) - \Delta P_{\text{opt}}(I_{\text{WGM}} > I_{\text{th}}))\). As the microlaser’s input-output curve \(P_{\text{opt}}(I_{\text{WGM}})\) can be derived from \(V_{\text{LIA}}^\dagger(I_{\text{WGM}})\) by integration,

\[
P_{\text{LIA}} = \int_0^{I_{\text{WGM}}} V_{\text{LIA}}^\dagger(I_{\text{WGM}}') dI_{\text{WGM}}' \propto P_{\text{opt}}(I_{\text{WGM}}) + C,
\]

the value of the laser threshold current is directly accessible.

**Figure 4:** Experimental data for all-electrical threshold-current determination with a phase-sensitive method. Two different configurations with a detector bias of -4 (black squares) and -8 V (blue circles) are used. (a) LIA-output voltage, originating from the time-varying voltage drop across a resistor in series with the photodetector, against the laser current. Linear curves are fitted to the upper branches (laser current greater than 90 \(\mu\)A). (b) Subtracting the linear trend superimposed to \(V_{\text{LIA}}\) yields this curve, which closely resembles the derivative of the laser’s input-output curve (normalized). (c) Numerical integration (cf. Eq. (2)) gives the input-output curve \(P_{\text{LIA}}\) (normalized), from which the threshold current can be extracted.
In Fig. 4, we display experimental data obtained in two threshold-determination experiments with two exemplary detector bias voltages \( V_D \) of -4 and -8 V, respectively (500 \( \Omega \) readout resistance \( R \)) over a range of laser currents between 8 and 160 \( \mu \)A (3 and 9.5 V laser bias, respectively). The sinusoidal amplitude for the small signal modulation was chosen as 0.1 V at a frequency of 102 kHz. The LIA readout \( V_{\text{LIA}} \) which varies with laser current can be inspected in Fig. 4(a). As described previously (cf. Eq. (1)), \( V_{\text{LIA}} \) scales linearly with \( I_{\text{WGM}} \) at high currents. At lower laser currents, the data show a transition into a linear trend with a clear kink at around 50 \( \mu \)A. This is illustrated by the pseudo-LIA voltage \( V_{\text{LIA}}^{\dagger} \) shown in Fig. 4(b) for which this superimposed linear function was subtracted from \( V_{\text{LIA}} \). It closely resembles the derivative of the microlaser’s input-output curve. Numerical integration of \( V_{\text{LIA}}^{\dagger} \) (cf. Eq. (2)) retrieves the microlaser’s input-output curve as shown in Fig. 4(c). Linear fits to the high-current branches allow for an extraction of the laser threshold current defined as the abscissa intercept with the linear functions. In order to verify the result, this experiment was carried out in more than ten different configurations (\( R \in [75:10k] \Omega \) and \( V_D \in [-8:0] \) V) yielding the threshold current (54 \( \pm \) 4) \( \mu \)A.

In summary, we have demonstrated the realization of on-chip microscale photodetection and its application to characterize a monolithically-integrated cQED-enhanced device. Using such integrated microdetectors, we all-electrically determined the threshold current of a WGM microlaser via a lock-in technique. The results presented in this report show promise for the exploration of self-pulsing and chaos for, e.g., random number generation and chaos-based secure communication, as it is possible to read out the laser-induced photocurrent and use it to modulate the current flowing through the microlaser in an on-chip feedback-type experiment. Beyond this, the presented concept of a monolithically integrated microlaser-photodetector pair might be utilized for on-chip chemical sensing applications. To realize such micro-scale absorption spectroscopy, WGM lasers emitting in the near-infrared [31] and operating at room temperature [32] can be exploited in future.

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